



# UNITED STATES PATENT AND TRADEMARK OFFICE

UNITED STATES DEPARTMENT OF COMMERCE  
United States Patent and Trademark Office  
Address: COMMISSIONER OF PATENTS AND TRADEMARKS  
P.O. Box 1450  
Alexandria, Virginia 22313-1450  
www.uspto.gov

APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/914,330	02/12/2002	Philip Stephen Goodall	9052-89	3562

20792 7590 05/20/2003

MYERS BIGEL SIBLEY & SAJOVEC  
PO BOX 37428  
RALEIGH, NC 27627

EXAMINER

GURZO, PAUL M

ART UNIT	PAPER NUMBER
----------	--------------

2881

DATE MAILED: 05/20/2003

Please find below and/or attached an Office communication concerning this application or proceeding.

<b>Office Action Summary</b>	Applicant(s)	
	GOODALL ET AL.	
	Applicant N .	09/914,330
Examiner	Paul Gurzo	Art Unit
		2881

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

### Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133).
- Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

### Status

- 1) ☒ Responsive to communication(s) filed on 31 March 2003.
- 2a) ☒ This action is **FINAL**.                      2b) ☐ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

### Disposition of Claims

- 4) ☒ Claim(s) 1-34 is/are pending in the application.
- 4a) Of the above claim(s) \_\_\_\_\_ is/are withdrawn from consideration.
- 5) ☐ Claim(s) \_\_\_\_\_ is/are allowed.
- 6) ☒ Claim(s) 1-34 is/are rejected.
- 7) ☐ Claim(s) \_\_\_\_\_ is/are objected to.
- 8) ☐ Claim(s) \_\_\_\_\_ are subject to restriction and/or election requirement.

### Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☐ The drawing(s) filed on \_\_\_\_\_ is/are: a) ☐ accepted or b) ☐ objected to by the Examiner.
- Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
- 11) ☒ The proposed drawing correction filed on 31 March 2003 is: a) ☒ approved b) ☐ disapproved by the Examiner.
- If approved, corrected drawings are required in reply to this Office action.
- 12) ☐ The oath or declaration is objected to by the Examiner.

### Priority under 35 U.S.C. §§ 119 and 120

- 13) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☐ All b) ☐ Some \* c) ☐ None of:
1. ☐ Certified copies of the priority documents have been received.
2. ☐ Certified copies of the priority documents have been received in Application No. \_\_\_\_\_.
3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).
- \* See the attached detailed Office action for a list of the certified copies not received.
- 14) ☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application).
- a) ☐ The translation of the foreign language provisional application has been received.
- 15) ☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121.

### Attachment(s)

- |  |   |
|--|---|
| 1) <input type="checkbox"/> Notice of References Cited (PTO-892)                             | 4) <input type="checkbox"/> Interview Summary (PTO-413) Paper No(s). _____  |
| 2) <input type="checkbox"/> Notice of Draftsperson's Patent Drawing Review (PTO-948)         | 5) <input type="checkbox"/> Notice of Informal Patent Application (PTO-152) |
| 3) <input type="checkbox"/> Information Disclosure Statement(s) (PTO-1449) Paper No(s) _____ | 6) <input type="checkbox"/> Other: _____                                    |

## DETAILED ACTION

### *Claim Rejections - 35 USC § 103*

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

Claim 1 and 28-30 stand rejected under 35 U.S.C. 103(a) as being unpatentable over Houk et al. (5,313,067) and further in view of Kellner et al. (Analytical Chemistry, Pp 827-828, 1998). Houk et al. teach an instrument comprising an Inductively Coupled Plasma Source Mass Spectrometer (ICP-MS) wherein the ions transmitted by the mass spectrometer are detected with high selectivity (col. 2, lines 61-64 and col. 4, lines 17-20). They do not teach the multi-dimensional detector system, but Kellner et al. teach that the multi-dimensional approach to analyzing samples is already well established (page 827, line 27). Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to use this multi-dimensional approach with an ICP-MS because the multidimensionality of the data provides more information than separate techniques.

Regarding claims 28-30, the above-applied prior art does not teach the detecting the claimed concentrations or species. However, Houk et al. teach a mass spectrometer that employs a plasma and is intended primarily for radionuclides (col. 2, lines 2-4). Further, it is obvious that the selectivity is enhanced by specific detection of the transmitted ions. Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to analyze

Art Unit: 2881

these concentrations with the specific species using specific detection so that the detection can be more accurate with a higher sensitivity.

Claims 2-5, and 13-14 stand rejected under 35 U.S.C. 103(a) as being unpatentable over Houk et al. (5,313,067) in view of Kellner et al. (Analytical Chemistry, Pp 827-828, 1998), and further in view of Hu et al. (GB 2288273 A).

Regarding claims 2 and 3, the above-applied prior art does not depict a plurality of sub-systems, but Hu et al. show depict this system in Figure 1 with reference to 50 and 68.

Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to use this sub-system approach with an ICP-MS because the multi sub-systems will help produce a high selectivity because of the unitary response.

Regarding claims 4, 5, and 13, it is an obvious matter of design choice to use a specific and non-specific detector and to use the non-specific ion counting device as the second detector. Further, it would be obvious to correlate them with a high resolution for increased detection results.

Regarding claim 14, Hu et al. teach including an electron multiplier in the detector system (page 8, lines 13-18).

Claim 6 stands rejected under 35 U.S.C. 103(a) as being unpatentable over Houk et al. (5,313,067) in view of Kellner et al. (Analytical Chemistry, Pp 827-828, 1998) in view of Hu et al. (GB 2288273 A), and further in view of Dowell (GB 2273200 A). The above-applied prior art does not teach co-incidence detection of the transmitted ions, but Dowell teaches two detector portions (38A and 38B) arranged so that the ion beams strike them in them claimed co-incident manner (page 9, lines 12-14 and Fig. 1, ref. 38A and 38B). Therefore, it would have been

Art Unit: 2881

obvious to one of ordinary skill in the art at the time the invention was made to use this co-incident detection for increased accuracy and calibration.

Claim 7 stands rejected under 35 U.S.C. 103(a) as being unpatentable over Houk et al. (5,313,067) in view of Kellner et al. (Analytical Chemistry, Pp 827-828, 1998) in view of Hu et al. (GB 2288273 A) in view of Dowell (GB 2273200 A), and further in view of Stuke (GB 2219432). The above-applied prior art does not teach the detection based on optical spectrometry, but Stuke explains that information can be derived by means of mass spectrum information and optical-spectroscopic information (page 6, lines 15-23). Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to use optical spectrometry for another way to accurately detect the transmitted ion beam.

Claims 8-10 stand rejected under 35 U.S.C. 103(a) as being unpatentable over Houk et al. (5,313,067) in view of Kellner et al. (Analytical Chemistry, Pp 827-828, 1998) in view of Hu et al. (GB 2288273 A) in view of Dowell (GB 2273200 A) in view of Stuke (GB 2219432), and further in view of Baba et al. (5,679,950).

The above-applied prior art does not teach detection via resonance scattering processes, but Baba et al. teach that ions are observed for mass spectrometry through resulting changes in the resonance scattering (Abstract). In addition, Stuke teaches detection via laser-induced fluorescence (page 6, lines 15-20). Further, it is obvious that the means for collecting and detecting the resonantly scattered photons is done efficiently. Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to use resonance scattering and laser-induced fluorescence for increased ion detection accuracy.

Art Unit: 2881

Claim 11 stands rejected under 35 U.S.C. 103(a) as being unpatentable over Houk et al. (5,313,067) in view of Kellner et al. (Analytical Chemistry, Pp 827-828, 1998) in view of Hu et al. (GB 2288273 A) in view of Dowell (GB 2273200 A) in view of Stuke (GB 2219432) in view of Baba et al. (5,679,950), and further in view of Twerenhold (5,640,010).

The above-applied prior art does not teach temporal and spatial resolution, but Twerenhold teaches his claimed mass spectrometer having a high spatial resolution (col. 3, lines 49-54). He goes on to explain calculations based on the spatial and temporal resolutions (col. 7, lines 52-67 and col. 8, lines 1-41). Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to use spatial and temporal resolutions because the sensitivity can be improved by several orders of magnitude.

Claim 12 stands rejected under 35 U.S.C. 103(a) as being unpatentable over Houk et al. (5,313,067) in view of Kellner et al. (Analytical Chemistry, Pp 827-828, 1998) in view of Hu et al. (GB 2288273 A) in view of Dowell (GB 2273200 A) in view of Stuke (GB 2219432) in view of Baba et al. (5,679,950) in view of Twerenhold (5,640,010), and further in view of Karanassios (6,184,982). The above-applied prior art does not teach the imaging photomultiplier tube, but Karanassios shows an example of a photomultiplier tube detection with respect to spectrometry (col. 14, lines 15-67 and col. 15 and 16). Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to use this detection as another way to increase the sensitivity and detection of the sub-system.

Claims 15-17 stand rejected under 35 U.S.C. 103(a) as being unpatentable over Houk et al. (5,313,067) in view of Kellner et al. (Analytical Chemistry, Pp. 827-828, 1998), and further in view of Hager (6,028,308). The above-applied prior art does not teach spread reduction to

Art Unit: 2881

compress bandwidth or the acceleration or deceleration of the ion beams. However, Hager teaches a means for reducing the relative spread of the ion beam energies (col. 4, lines 21-24). He continues to explain that the ions can be accelerated through the fringing field (col. 10, lines 47-59). It is inherent that the reduction in the relative spread of the ion beams will result in a compression of the optical bandwidth of the transmitted ions. Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to reduce the energy spread to produce an enhancement of the ion signal with better sensitivity.

Claims 18-20 stand rejected under 35 U.S.C. 103(a) as being unpatentable over Houk et al. (5,313,067) in view of Kellner et al. (Analytical Chemistry, Pp 827-828, 1998) in view of Holmes (GB 2267994 A), and further in view of Hager (6,028,308).

Regarding claim 18, the above-applied prior art does not teach a front-end collision/reaction cell to reduce the spread of the ion beam energies. However, Holmes teaches a collision cell that is between the ion source and the mass spectrometer (page 5, lines 4-18 and Fig. 1, ref. 6 and 7). Holmes does not teach the ion beam energy reduction, but Hager teaches a means for reducing the relative spread of the ion beam energies as applied above. Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to use the claimed collision cell to reduce the energy spread to produce an enhancement of the ion signal with better sensitivity.

Regarding claims 19 and 20, Hager teaches accelerating the ion beam as well as manipulating the ion beam energies. It is an obvious matter of design choice to bring the ion beam into resonance within the detection volume of the detector so that proper detection can occur with increased sensitivity.

Claim 21 stands rejected under 35 U.S.C. 103(a) as being unpatentable over Houk et al. (5,313,067) in view of Kellner et al. (Analytical Chemistry, Pp 827-828, 1998) in view of Hu et al. (GB 2288273 A) in view of Dowell (GB 2273200 A) in view of Stuke (GB 2219432), and further in view of Colvard (5,872,629). The above-applied prior art does not teach the use of Doppler shifting. However, Colvard teaches shifting by such suitable means as Doppler shifting the beams (col. 8, lines 13 -30). Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to use the Doppler effect to ensure that the ions to be detected come into resonance with the exciting laser to prevent optical trapping.

Claims 22-27 stand rejected under 35 U.S.C. 103(a) as being unpatentable over Houk et al. (5,313,067) in view of Kellner et al. (Analytical Chemistry, Pp 827-828, 1998) in view of Dowell (GB 2273200 A), and further in view of Hu et al. (GB 2288273 A).

Regarding claims 22-26, the above-applied prior art does not depict the claimed exit slit assemblies. However, Dowell teaches that data from the ion beams is received by analysis equipment (col. 5, lines 49-53). It is inherent that the claimed multiple exit slit assembly is incorporated (Fig. 1, ref. 38A, 38B). Claims 23-26 are obvious matters of design choice. The applicant has not mentioned that various slit assemblies will give rise to any unexpected results, therefore the prior art teaches on each of these modifications.

Regarding claim 27, Hu et al. teach the use of electron multiplier devices and it is a matter of design choice to use it for the non-specific ion detectors (page 8, lines 13-18).

Claim 31 stands rejected under 35 U.S.C. 103(a) as being unpatentable over Houk et al. (5,313,067) in view of Kellner et al. (Analytical Chemistry, Pp 827-828, 1998), and further in view of Lucatorto et al. (4,734,579). The above-applied prior art does not teach optical isotope



Art Unit: 2881

shifts, but Lucatorto et al. teach a resonant process that exploits the optical isotope shift to enhance the number of ions of a selected isotope relative to the number of ions of the background isotope (col. 7, lines 48-51). Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to use the claimed shifts to enhance the selectivity.

Claim 32 stands rejected under 35 U.S.C. 103(a) as being unpatentable over Houk et al. (5,313,067) in view of Kellner et al. (Analytical Chemistry, Pp 827-828, 1998) in view of Lucatorto et al. (4,734,579), and further in view of Colvard (5,872,629). The above-applied prior art does not teach the acceleration of the transmitted ions with subsequent Doppler shifting. But Lucatorto et al. teach a system of ion injection optics that serves to extract the ions and accelerate them in a suitable manner for the mass spectrometer (col. 5, lines, 29-33). They do not teach the subsequent Doppler shifting, but Colvard teaches the Doppler shifting of the ion beams as described above (col. 8, lines 20-30). Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to use this acceleration and shifting to further enhance the selectivity.

Claim 34 stands rejected under 35 U.S.C. 103(a) as being unpatentable over Houk et al. (5,313,067) in view of Kellner et al. (Analytical Chemistry, Pp 827-828, 1998), and further in view of Dowell (GB 2273200 A). Dowell teaches two detector portions (38A and 38B) arranged so that the ion beams strike them in their claimed co-incident manner (page 9, lines 12-14 and Fig. 1, ref. 38A and 38B). It would be obvious to then improve the detection limit so that the non-specific background is reduced so that detecting the low concentrations of isotopes will occur with higher sensitivity.

### *Response to Arguments*

Applicant's arguments filed March 31, 2003 have been fully considered but they are not persuasive. In response to Applicant's primary argument that the combination of the Houk and Kellner reference combination is no proper, the examiner maintains that Kellner teaches that the use of a multi-dimensional approach is already well established in the art of both chromatography as well as GC-MS and LC-MS and tandem mass spectrometry. These examples of mass spectrometry as well known in the art as well as ICP-MS, therefore, the teaching of the well-known use of a multidimensional approach can obviously be extended to include many types of mass spectrometry. In response to Applicant's arguments based on subsequent dependent claims, the examiner maintains that, though the prior art does not explicitly state the claim language in identical fashion, the secondary references are viewed as functional equivalents and, as such, teach on the claimed limitations.

### *Conclusion*

The prior art made of record and not relied upon is considered pertinent to applicant's disclosure.

Freedman et al., U.S. Patent No. 5,471,059 <sup>cited in the previous office action,</sup> teach a multiple detector system for detecting charged particles.

**THIS ACTION IS MADE FINAL.** Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

Art Unit: 2881


A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Paul Gurzo whose telephone number is (703) 306-0532. The examiner can normally be reached on M-Thurs. 7:30 - 6:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, John Lee can be reached on (703) 308-4116. The fax phone numbers for the organization where this application or proceeding is assigned are (703) 872-9318 for regular communications and (703) 872-9319 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-0956.

PMG  
May 16, 2003

  
JOHN R. LEE  
SUPERVISORY PATENT EXAMINER  
TECHNOLOGY CENTER 2800